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Sheet 1 of 1 SERIAL NO. ATTY, DOCKET NO. U.S. DEPARTMENT OF COMMERCE FORM PTO-1449 **New Application** PATENT AND TRADEMARK OFFICE 107348-00368 APPLICANT LIST OF REFERENCES CITED BY APPLICANT TAWA, et al. GROUP (Use several sheets if necessary) FILING DATE Unknown October 1, 2003 U.S. PATENT DOCUMENTS FILING SUB-DATE **DOCUMENT** CLASS **EXAMINER** CLASS NAME DATE NO. INITIAL AΑ AB AC AD ΑE AF FOREIGN PATENT DOCUMENTS TRANSLATION YES NO PART. SUB-DOCUMENT CLASS CLASS COUNTRY DATE NO. XX Japan 7/28/1986 61-16711 AG ΑH Αi ΑJ AK AL. OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.) AM AN AO DATE CONSIDERED **EXAMINER**

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